

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10734472	CHARETTE, MARC F.
	Examiner	Art Unit
	Wang, Chang-Yu	1649

SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES

Search Notes	Date	Examiner
sequence search: SEQ ID NO:2 and aa. 30-431, aa. 30-292, 292-330, 292-431 of SEQ ID NO:21. See sequence search results in SCORE.	5/19/09	CYW
EAST, STN: search strategy attached (updated)	5/19/09	CYW
Inventor name search: EAST, STN, PALM (updated)	5/19/09	CYW
PLUS search from STIC. See search results in eDAN (4/24/09)	5/19/09	CYW

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

/C.Y. W./
Examiner.Art Unit 1649